

1.1 Scope.

This specification covers the detail requirements for a complete monolithic 10-bit, 20 Msps A/D converter with an on-chip, high performance track-and-hold amplifier (THA).

1.2 Part Number.

The complete part number per Table 1 of this specification is as follows:

Device	Part Number
-1	AD773ASD/883B

1.2.3 Case Outline.

See Appendix 1 of General Specification ADI-M-1000: package outline:

(X)	Package	Description
D	D-28	28-Pin Side Brazed Ceramic DIP

1.3 Absolute Maximum Ratings. ($T_A = +25^\circ\text{C}$ unless otherwise noted)

AV_{DD} to AGND	-0.5 V to +6.5 V
AV_{SS} to AGND	-6.5 V to +0.5 V
DV_{DD} , DRV_{DD} to DGND	-0.5 V to +6.5 V
AGND to DGND	-1 V to +1 V
AV_{DD} to DV_{DD}	-6.5 V to +6.5 V
Clock Input to DGND	-0.5 V to $DV_{DD} + 0.5$ V
Digital Outputs to DGND	-0.5 V to $DV_{DD} + 0.3$ V
REF IN to AV_{DD}	AV_{SS} to 0 V
REF IN to AV_{SS}	0 V to AV_{DD}
V_{INA} , V_{INB} , REF IN to AGND	-6.5 V to +6.5 V
Storage Temperature Range	-65°C to $+150^\circ\text{C}$
Lead Temperature Range (Soldering 10 sec)	$+300^\circ\text{C}$

1.5 Thermal Characteristics.

Thermal Resistance: $\theta_{JC} = 25^\circ\text{C}/\text{W}$
 $\theta_{JA} = 60^\circ\text{C}/\text{W}$

REV. A

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One Technology Way, P.O. Box 9106, Norwood, MA 02062-9106, U.S.A.
 Tel: 617/329-4700 Fax: 617/326-8703

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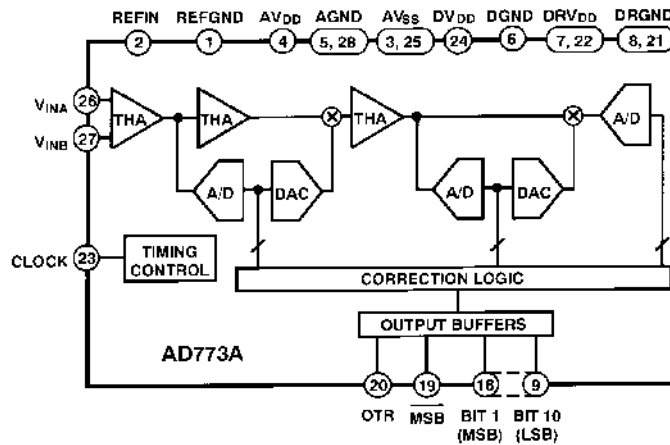
Table 1.

Test	Symbol	Device	Design Limit @ +25°C	Sub Group 1	Sub Group 2, 3	Test Condition	Units
Resolution	RES	-1	10	10	10		Bits
Zero Error	B _{POE}	-1	0.5	0.5			±% FSR max
Gain Error	A _F	1	0.5	0.5			±% FSR max
Zero Error Drift	TCB _{POE}	1			3.5	External 2.5 V Reference	±% FSR max
Gain Error Drift	TCA _{EXT}	-1			2	External 2.5 V Reference	±% FSR max
Power Supply Rejection	PSR	-1	18	18	18	See Note 1	±mV/V max
Analog Input Range	V _{IN}	-1	1	1	1		V p-p
Input Resistance	R _{IN}	-1	200				kΩ
Input Capacitance	C _{IN}	-1	10				pF
Power Dissipation	PD	-1	1.2	1.2	1.2		Watts max
Power Supply Current	I _{AVDD}	-1	80	80	80		mA max
	I _{AVSS}		140	140	140		
	I _{DVDD}		20	20	20		
	I _{DRVDD}		15	15	15		
Signal-to-Noise Distortion Ratio	S/(N+D)	-1	51	51	51	f _{IN} = 1 MHz; f _S = 20 MHz	dB min
Total Harmonic Distortion	THD	-1	-56	-56	-56	f _{IN} = 1 MHz; f _S = 20 MHz	dB max
Logic Input High Voltage	V _{IH}	-1	3.5	3.5	3.5		V min
Logic Input Low Voltage	V _{IL}	-1	0.5	0.5	0.5		V max
Logic Input High Current (CLK)	I _{IH}	-1	10	10	10		+ μA max
Logic Input Low Current (CLK)	I _{IL}	-1	10	10	10		± μA max
Logic Output High Voltage	V _{OIH}	-1	2.4	2.4	2.4	I _{SOURCE} = 500 μA	V min
Logic Output Low Voltage	V _{OL}	-1	0.4	0.4	0.4	I _{SINK} = 1.6 mA	V min
Clock Period	t _C	1	50	50	50		ns min
Output Delay	t _{OD}	-1	20				ns min
Pipeline Delay	t _{PD}	-1	4				Clock Cycles max
Clock Pulse Width High	t _{CH}	-1	25				ns min
Clock Pulse Width Low	t _{CL}	-1	25				ns min

NOTES

¹Test conditions for PSR: 4.75 V ≅ AV_{DD} ≅ 5.25 V, 4.75 V ≅ DV_{DD} ≅ 5.25 V, -4.75 V ≅ AV_{SS} ≅ -5.25 V, 4.75 V ≅ DRV_{DD} ≅ 5.25 V.

3.2.1 Functional Block Diagram and Terminal Assignments.



D Package

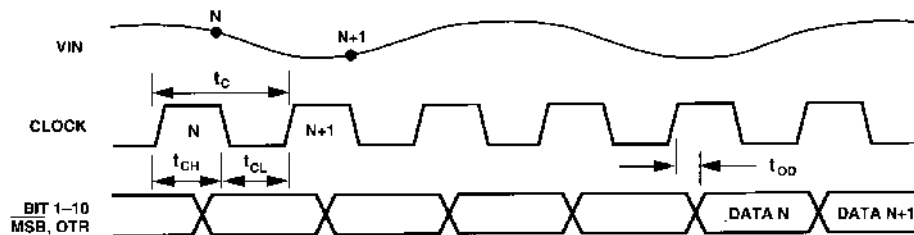
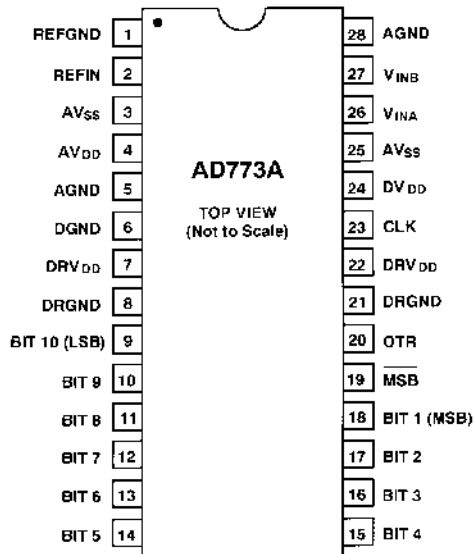


Figure 1. Timing Diagram

AD773A

3.2.4 Microcircuit Technology Group.

This microcircuit is covered by technology group (93).

4.2.1 Life Test/Burn-In Circuit.

Steady state life test is per MIL-STD-883 Method 1005. Burn-in is per MIL-STD-883 Method 1015 test condition (B).

